Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/050,741	ZIEMKOWSKI, TED	
Examiner	Art Unit	
Kevin M. Gagliostro	2615	

SEARCHED			
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED			IED
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
interference searched on U.S. PGPUB text search in EAST usnig .CLM.	7/21/2005	KG
Synchroniz\$3 or Simultaneous\$2 (first and second and third) or (one and two and three) Exposure Camera or (image with capture	7/21/2005	KG
(light with pulse) (receiv\$3) (view\$3 with angl\$2) (tim\$3 or delay\$2)	7/21/2005	KG
(zero or none or no) with (luminosity or luminance) (manual\$2) with (mod\$2 or set\$4 or switch\$3)	7/21/2005	KG
ALL OF THE ABOVE IS SEARCH METHOD IF MATERIAL GOES TO ALLOWANCE	7/21/2005	KG

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Application/Control No.	Applicant(s)/Patent under Reexamination
10/050,741	ZIEMKOWSKI, TED
Examiner	Art Unit
Tuan V. Ho	2615

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Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
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207.99,143,153,	8/1der	
y. Vu	8/10/05	K
Vu LE L. YE		/
L. DEUYEN	(/10/05	4
H. WOVG		1
T. VO V. TRAN		
YOGESH A.		1
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